

<b>Notice of References Cited</b>	Application/Control No. 10/560,158	Applicant(s)/Patent Under Reexamination MALDZIUNAS, ARVYDAS ANTA	
	Examiner Pascal M. Bui-Pho	Art Unit 2878	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,084,228	07-2000	Hill et al.	250/203.4
*	B	US-5,553,775	09-1996	Kato et al.	236/49.3
*	C	US-5,022,930	06-1991	Ackerman et al.	136/251
*	D	US-4,362,931	12-1982	Maruko et al.	250/203.4
*	E	US-6,031,177	02-2000	Voss, Paul B.	136/244
*	F	US-6,781,106	08-2004	Sumiya, Kazuyoshi	250/203.4
*	G	US-4,297,572	10-1981	Carlton, Richard J.	250/203.4
*	H	US-4,225,781	09-1980	Hammons, Burrell E.	250/203.4
*	I	US-5,153,429	10-1992	Takahashi, Tadahiro	250/239
*	J	US-5,072,105	12-1991	Osawa, Takashi	250/206.1
*	K	US-4,361,758	11-1982	Rotolo, Guglielmo E.	250/203.4
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.